Supplementary Information

Deep-subwavelength control of acoustic waves in an ultra-compact metasurface lens

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Supplementary Figure 1 | Schematic diagram of wave interactions with a subwavelength slit. The slit has a rectangular cross-section with width *w* and thickness *h*. The pressure field of incident waves is normalized to 1 Pa.

Supplementary Figure 2 | The comparisons of transmission and reflection coefficients of a single slit between theoretical calculations (solid lines) and numerical simulations (marks). The calculation and simulation for (a, b) T_{n} , (c, d) R_{n} , (e, f) T_{g} and (g, h) R_{g} are carried out on different slit parameters. The slit width increases from 0.005*λ* to 0.25*λ* with a step of 0.005*λ* at different thicknesses (*h* = 0.01*λ*, 0.05*λ*, 0.15*λ*, 0.25*λ*, 0.4*λ*).

Supplementary Figure 3 | (a) Calculated and **(b)** simulated pressure field after a plane wave transmits through a user-defined acoustic metasurface. The thickness, spacing, and slit number in the acoustic metasurface are 0.1*λ*, 0.15*λ* and 19, respectively. The slit widths decrease from 0.1*λ* to 0.01*λ* with a step of 0.01*λ* from the center to the side.

Supplementary Figure 4 | (a) The amplitude and **(b)** phase of the acoustic signals generated by the plane wave speaker at selected frequencies: 1942Hz (circles), 3294Hz (squares), 4129Hz (diamonds) and 5185Hz (triangles). The measurements were performed along the 45^o diagonal path in front of the speaker on which the microphone slides. The distance of the measurement locations was recorded with respect to a reference point on the frame diagonal. The measured phase data was fitted using linear least squares, and the parameters are listed in Supplementary table 3.

Anechoic Chamber

Supplementary Figure 5 | Schematic of the experimental setup for acoustic field measurements.

Supplementary Table 1: Optimized slit widths of the acoustic metasurface lens for far-field sound focusing.

Supplementary Table 2: Optimized slit widths of the near-field metasurface lens.

Supplementary Table 3: The linear least square fitting parameters of the measured phases.

Supplementary Note 1. The Derivation of transmission and reflection coefficients

Consider an amplitude- normalized plane wave with a tangential component of wave-vector α ₀ incident on a rigid plate, as shown in Supplementary Fig. 1. The slit has a rectangular cross-section with width *w* and thickness *h*. Under this insonfication, the expression of the pressure field above and below the slit can be, respectively, written as

$$
P_{\rm a} = P_{\rm I} + P_{\rm r} = e^{i\alpha_0 x + i\eta_0 z} + \int\limits_{-\infty}^{+\infty} R(\alpha) e^{i\alpha x - i\eta z} d\alpha \tag{A.1}
$$

and

$$
P_{b} = P_{t} = \int_{-\infty}^{+\infty} T(\alpha) e^{i\alpha x + i\eta(z-h)} d\alpha , \qquad (A.2)
$$

where $i = \sqrt{-1}$, $\eta_0 = \sqrt{k_0^2 - \alpha_0^2}$ is the *z* component of the incident-wave vector, *α* and $\eta = \sqrt{k_0^2 - \alpha^2}$ are the wave vectors of high-order diffraction along *x* and *z* directions, respectively; $k_0 = \omega / c$ is the wave-vector of the incident wave in air (ω is the angular frequency and *c* is the acoustic velocity in air); $R(\alpha)$ and $T(\alpha)$ are the reflection and transmission coefficients, respectively. By making Fourier transforms of each waveguide modes, $R(\alpha)$ and $T(\alpha)$ can be expanded $as¹$

$$
R(\alpha) = \delta(\alpha - \alpha_0) + \sum_{j \ge 0} R_j W_j(\alpha) / \eta
$$
 (A.3)

$$
T(\alpha) = \sum_{j\geq 0} T_j W_j(\alpha) / \eta \tag{A.4}
$$

where δ is the Dirac delta function, and

$$
W_j(\alpha) = \int_{-w/2}^{w/2} e^{-i\alpha x} \cos(\frac{j\pi}{w} x) dx.
$$
 (A.5)

Inside the slit, the pressure field is also expanded in terms of the waveguide modes, which is expressed as

$$
P_{\text{in}} = \sum_{j\geq 0} \cos(\frac{j\pi}{w}x)[A_j e^{i\sqrt{k_0^2 - (\frac{j\pi}{w})^2}z} + B_j e^{-i\sqrt{k_0^2 - (\frac{j\pi}{w})^2}z}]
$$
(A.6)

where A_j and B_j are the pressure amplitudes of the forward and backward waves of *j*-th waveguide mode, and *j* is a positive integer.

In the case of a subwavelength slit, the pressure field can be sufficiently well described by the first term in the mode expansions (this means that only the fundamental mode $(j = 0)$ is retained)¹. Therefore, Supplementary equations 1-6 can be simplified to

$$
\begin{cases}\nP_{\mathbf{a}} = e^{i\alpha_0 x + i\eta_0 z} + e^{i\alpha_0 x - i\eta_0 z} + \int_{-\infty}^{+\infty} \frac{R_0 W_0(\alpha)}{\eta} e^{i\alpha x - i\eta z} \, d\alpha \\
P_{\mathbf{a}} = A_0 e^{ik_0 z} + B_0 e^{-ik_0 z} \\
P_{\mathbf{b}} = \int_{-\infty}^{+\infty} \frac{T_0 W_0(\alpha)}{\eta} e^{i\alpha x + i\eta(z - h)} \, d\alpha\n\end{cases} \tag{A.7-1}
$$

with $W_0(\alpha) = \int_{0}^{\frac{w}{2}}$ 0 / 2 $\alpha(x) = \int_{0}^{w/2} e^{-iax} dx = \frac{2\sin(w\alpha/2)}{2}$ *w* $W_0(\alpha) = \int_{\alpha}^{\infty} e^{-i\alpha x} dx = \frac{2 \sin(w\alpha)}{\alpha}$ Ξ, $= \int e^{-i\alpha x} dx = \frac{2 \sin(w\alpha/2)}{\alpha}$.

The normal velocities can then be obtained from $u = \frac{1}{x}$ $\rho\omega$ $=\frac{1}{i\rho\omega}\frac{\partial}{\partial}$ $u = \frac{1}{i\rho\omega} \frac{\partial p}{\partial z}$, and thus we have

$$
\begin{cases}\n u_{\mathbf{a}} = \frac{1}{\rho \omega} (\eta_0 e^{i\alpha_0 x + i\eta_0 z} - \eta_0 e^{i\alpha_0 x - i\eta_0 z} - \int_{-\infty}^{+\infty} R_0 W_0(\alpha) e^{i\alpha x - i\eta z} d\alpha) \\
 u_{\mathbf{a}} = \frac{k_0}{\rho \omega} (A_0 e^{ik_0 z} - B_0 e^{-ik_0 z}) \\
 u_{\mathbf{b}} = \frac{1}{\rho \omega} (\int_{-\infty}^{+\infty} T_0 W_0(\alpha) e^{i\alpha x + i\eta(z - h)} d\alpha)\n\end{cases} \tag{A.7-2}
$$

where ρ is the mass density of air. According to the boundary conditions, the pressure field and normal velocity at the interfaces (i.e., $z = 0$ and $z = h$) should be continuous. Combining the continuity conditions with Supplementary equation 7, we can determine the coefficients R_0 , T_0 , A_0 , and B_0 .

Firstly, we calculate the transmission and reflection coefficients $[T_n$ and $R_n]$ for a normally incident plane wave. Under the normal incidence $(\theta = 0)$, we have $\alpha_0 = (k_0 \sin \theta) = 0$ and $\eta_0 = k_0$. By substituting the initial conditions to Supplementary equation 7 and applying the boundary conditions at $z = 0$, we obtain

$$
\begin{cases}\n2 + \int_{-\infty}^{+\infty} \frac{R_0 W_0(\alpha)}{\eta} e^{i\alpha x} d\alpha = A_0 + B_0 \\
\int_{-\infty}^{+\infty} R_0 W_0(\alpha) e^{i\alpha x} d\alpha = -k_0 (A_0 - B_0)\n\end{cases}
$$
\n(A.8-1)

Similarly, at $z = h$

$$
\int_{-\infty}^{+\infty} \frac{T_0 W_0(\alpha)}{\eta} e^{i\alpha x} d\alpha = A_0 e^{ik_0 h} + B_0 e^{-ik_0 h}
$$
\n
$$
\int_{-\infty}^{+\infty} T_0 W_0(\alpha) e^{i\alpha x} d\alpha = k_0 (A_0 e^{ik_0 h} - B_0 e^{-ik_0 h})
$$
\n(A.8-2)

Note that although the slits are deep-subwavelength compared to the incident wave, they cannot be simply considered as points for all waves, especially the evanescent waves with large tangential wave-vectors. As the integration is performed for all wave components over $[-\infty, \infty]$, here we generalize the evaluation of $e^{i\alpha x}$ by averaging it on the whole slit width, to integrate out the *x*

dependence. Thus, we have $e^{iax} \approx \frac{1}{\epsilon} \int_{0}^{\frac{w}{2}}$ / 2 $e^{iax} \approx \frac{1}{\pi} \int_{0}^{\pi/2} e^{iax} dx = \frac{2\sin(w\alpha/2)}{2\pi}$ \int_{i}^{i} *iax* 1 $\int_{i}^{w/2}$ *iax w* $\frac{1}{w}$ $\int_{\alpha} e^{i\alpha x} dx = \frac{2 \sin(wa)}{\alpha w}$ σ_{α} 1 σ_{α} σ_{α} $2 \sin(w \alpha)$ $\approx \frac{1}{w} \int_{-w/2}^{\infty} e^{i\alpha x} dx = \frac{2 \sin(w\alpha/2)}{\alpha w}$. Substituting $e^{i\alpha x}$ and

 $W_0(\alpha) = \frac{2\sin(w\alpha/2)}{\alpha}$ into Supplementary equation 8, we therefore have

$$
\begin{cases}\nT_n = \int_{-\infty}^{\infty} \frac{T_0 W_0(\alpha)}{\eta} e^{i\alpha x} d\alpha = \frac{4Q e^{ik_0 h}}{(Q+1)^2 - (Q-1)^2 e^{2ik_0 h}} \\
R_n = 1 + \int_{-\infty}^{\infty} \frac{R_0 W_0(\alpha)}{\eta} e^{i\alpha x} d\alpha = \frac{Q-1}{Q+1} (T_n e^{ik_0 h} - 1)\n\end{cases} (A.9)
$$

with $Q = \frac{\kappa_0}{\epsilon_0}$ ² $\sqrt{k_0^2-\alpha^2}$ $Q = \frac{k_0}{\int \frac{1 - \cos(w\alpha)}{1 - \cos(w\alpha)}} d\alpha$ $W \sim \alpha^2$, lk $\stackrel{\alpha)}{=} d\alpha$ $\pi w - \alpha^2$, $lk_0^2 - \alpha$ ∞ $-\infty$ $=\frac{\kappa_0}{\pi w}\int\limits_{-\infty}^{\infty}\frac{1-\cos(w\alpha)}{\alpha^2\sqrt{k_0^2-\alpha^2}}d\alpha.$

Similar calculations are implemented to the grazing incidence by changing the initial conditions to $\alpha_0 = k_0$ and $\eta_0 = 0$, and finally we get

$$
\begin{cases}\nT_{\rm g} = \frac{2Qe^{ik_0h}\text{sinc}(k_0w/2)}{(Q+1)^2 - (Q-1)^2e^{2ik_0h}} \\
R_{\rm g} = \frac{T_{\rm g}e^{ik_0h}(Q-1) + \text{sinc}(k_0w/2)}{Q+1} - 1\n\end{cases}
$$
\n(A.10)

Supplementary Note 2. Characteristic parameters of the cylindrical waves (CWs)

Under uniform illumination by a (normal or grazing) plane wave, the acoustic wave scattered by a subwavelength slit can be regarded as a new point source that thus generates a CW. The excited CW can be characterized by two coefficients, *β* and *ϕ*. To extract the coefficients, a two-step procedure is adopted. Firstly, the pressure field is extracted through a numerical simulation. Then, using Eq. (1) in the main text, the coefficients are optimized by fitting the pressure field distribution over an interval ($w/2 \le r \le 10\lambda$). This procedure offers a rigorous numerical approach to calculate *β* and $φ$, and similar calculations are performed for different slit parameters. The slit width increases from 0.005*λ* to 0.2*λ* with a step of 0.005*λ* at different thicknesses (*h* = 0.05*λ*, 0.1*λ*, 0.3*λ*, 0.7*λ*, 0.9*λ*). The calculated *β* and *ϕ* for different slits are provided in the Source Data file. From these calculations, it can be found that both *β* and *ϕ* are relying on the slit width *w*, but independent of thickness *h*. To determine the relationship between the CWs and the slit parameters, *β* and *ϕ* are fitted as a polynomial function of slit width with the least-mean-square method.

Supplementary References

1. Takakura, Y. Optical resonance in a narrow slit in a thick metallic screen. *Phys. Rev. Lett*. 86, 5601 (2001).